Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V_{DSS}	-30	V
Gate-Source Voltage		V_{GSS}	±25	V
Continuous Drain Current (Note 6) V_{GS} = -10V	T_A = +25°C T_A = +70°C	I_D	-8.7 -7.0	A
Continuous Drain Current (Note 7) V_{GS} = -10V	T_C = +25°C T_C = +70°C	I_D	-30 -25	A
Continuous Drain Current (Note 6) V_{GS} = -5V	T_A = +25°C T_A = +70°C	I_D	-7.2 -5.8	A
Continuous Drain Current (Note 7) V_{GS} = -5V	T_C = +25°C T_C = +70°C	I_D	-30 -24	A
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)		I_{DM}	-80	A
Maximum Continuous Body Diode Forward Current (Note 6)		I_S	-3.6	A
Avalanche Current (Note 7) L=0.3mH		I_{AS}	-17.5	A
Avalanche Energy (Note 7) L=0.3mH		E_{AS}	64	mJ

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)		P_D	0.9	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	137	°C/W
	t<10s		65	°C/W
Total Power Dissipation (Note 6)		P_D	2.3	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	55	°C/W
	t<10s		26	°C/W
Thermal Resistance, Junction to Case (Note 7)		$R_{\theta JC}$	3.5	°C/W
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV_{DSS}	-30	-	-	V	V_{GS} = 0V, I_D = -250µA
Zero Gate Voltage Drain Current	I_{DSS}	-	-	-1.0	µA	V_{DS} = -30V, V_{GS} = 0V
Gate-Source Leakage	I_{GSS}	-	-	±100	nA	V_{GS} = ±25V, V_{DS} = 0V
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(TH)}$	-1.0	-2.0	-2.5	V	V_{DS} = V_{GS}, I_D = -250µA
Static Drain-Source On-Resistance	$R_{DS(ON)}$	-	13	20	mΩ	V_{GS} = -10V, I_D = -8A
		-	18.4	29		V_{GS} = -5V, I_D = -5A
Diode Forward Voltage	V_{SD}	-	-0.7	-1.2	V	V_{GS} = 0V, I_S = -1A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	-	1931	-	pF	V_{DS} = -15V, V_{GS} = 0V, f = 1.0MHz
Output Capacitance	C_{oss}	-	226	-	pF	
Reverse Transfer Capacitance	C_{rss}	-	168	-	pF	
Gate Resistance	R_g	-	10.9	-	Ω	V_{DS} = 0V, V_{GS} = 0V, f = 1MHz
Total Gate Charge V_{GS} = -5V	Q_g	-	8.8	-	nC	V_{DS} = -15V, I_D = -10A
Total Gate Charge V_{GS} = -10V	Q_g	-	16.5	-	nC	
Gate-Source Charge	Q_{gs}	-	2.6	-	nC	
Gate-Drain Charge	Q_{gd}	-	3.6	-	nC	
Turn-On Delay Time	$t_{D(ON)}$	-	8.2	-	ns	V_{GS} = -10V, V_{DD} = -15V, R_{GEN} = 3Ω, I_D = -10A
Turn-On Rise Time	t_R	-	14	-	ns	
Turn-Off Delay Time	$t_{D(OFF)}$	-	65	-	ns	
Turn-Off Fall Time	t_F	-	31.6	-	ns	
Reverse Recovery Time	t_{RR}	-	9.3	-	ns	I_F = -8A, di/dt = 500A/µs
Reverse Recovery Charge	Q_{RR}	-	12.2	-	nC	

Notes:
5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
7. Thermal resistance from junction to soldering point (on the exposed drain pad).
8. Short duration pulse test used to minimize self-heating effect.
9. Guaranteed by design. Not subject to product testing.

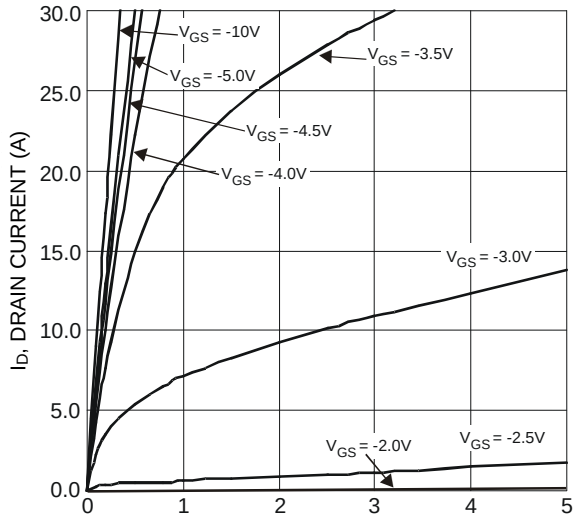


Figure 1 Typical Output Characteristics

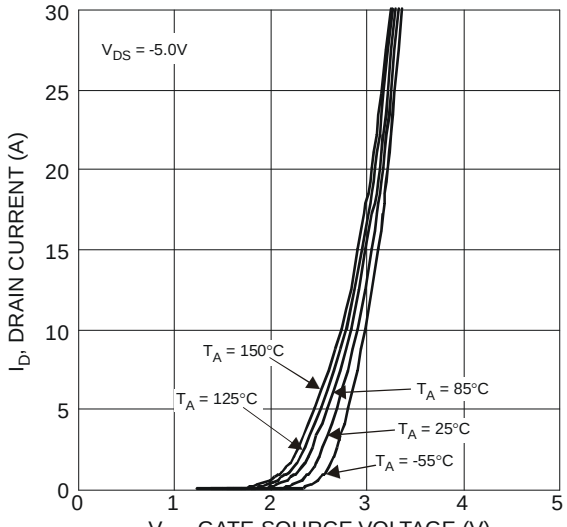


Figure 2 Typical Transfer Characteristics

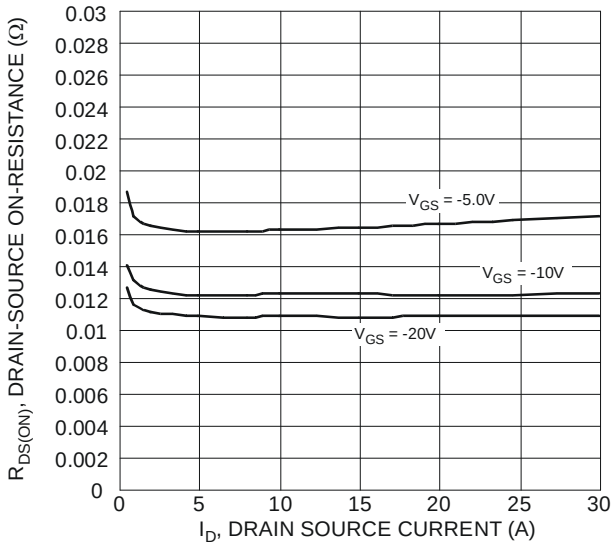


Figure 3 Typical On-Resistance vs. Drain Current and Gate Voltage

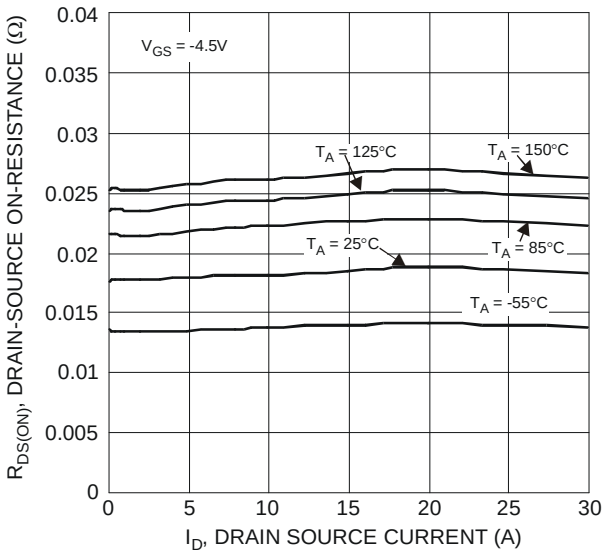


Figure 4 Typical On-Resistance vs. Drain Current and Temperature

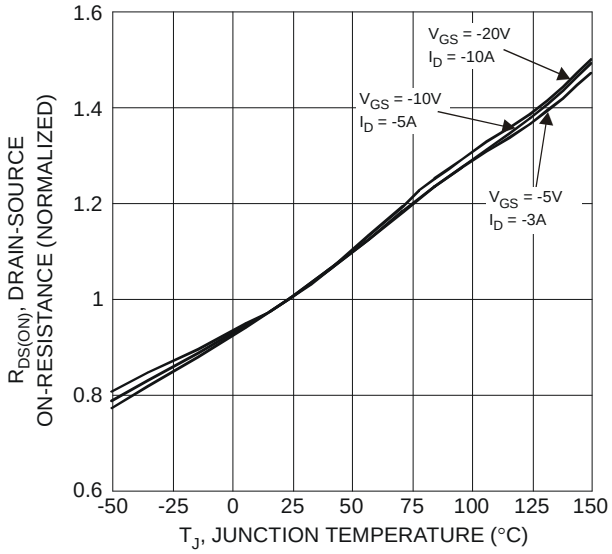


Figure 5 On-Resistance Variation with Temperature

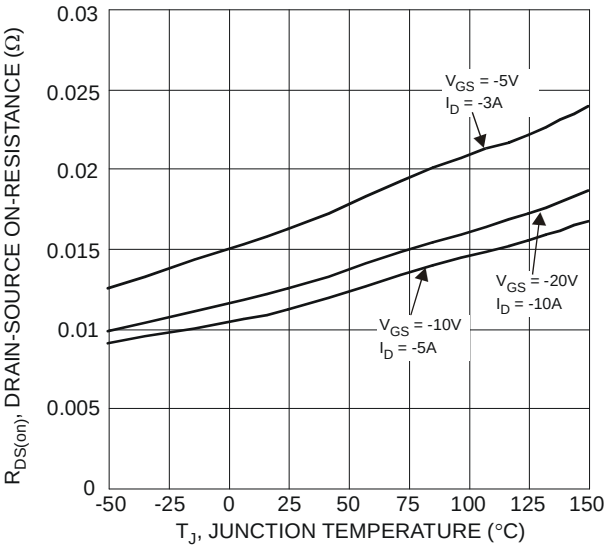


Figure 6 On-Resistance Variation with Temperature

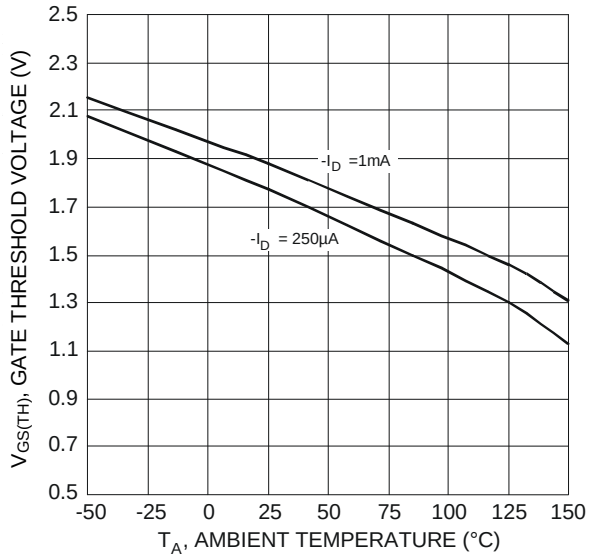


Figure 7 Gate Threshold Variation vs. Ambient Temperature

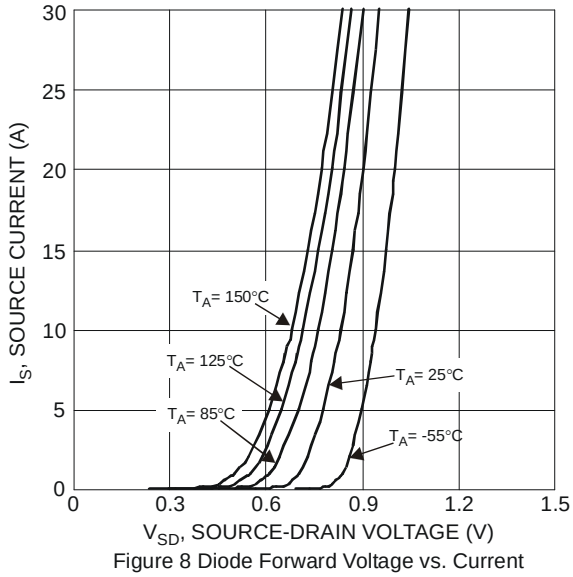


Figure 8 Diode Forward Voltage vs. Current

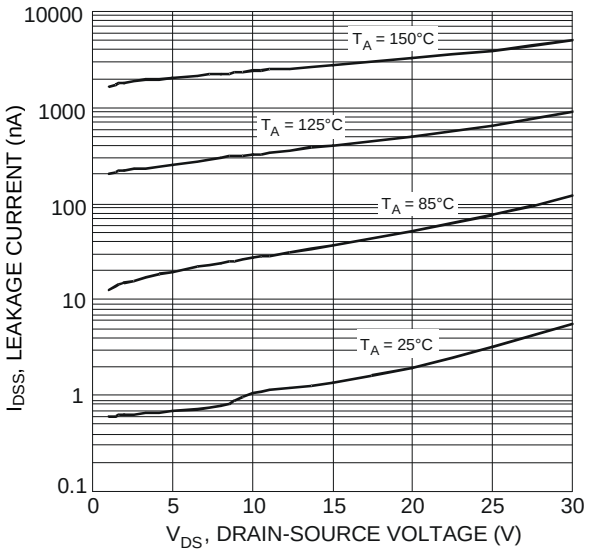


Figure 9 Typical Drain-Source Leakage Current vs. Voltage

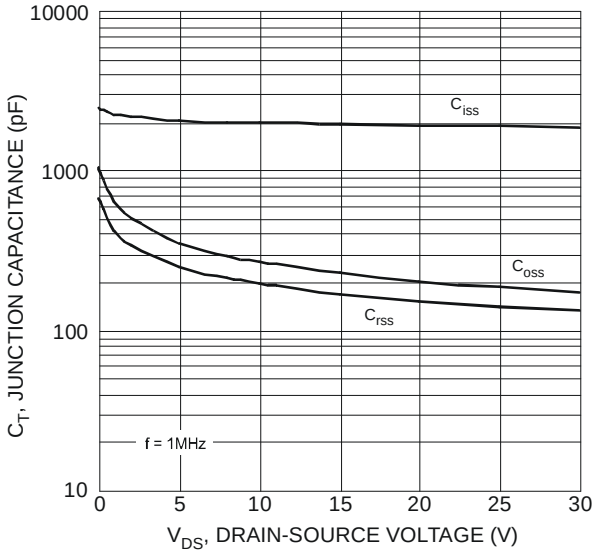


Figure 10 Typical Junction Capacitance

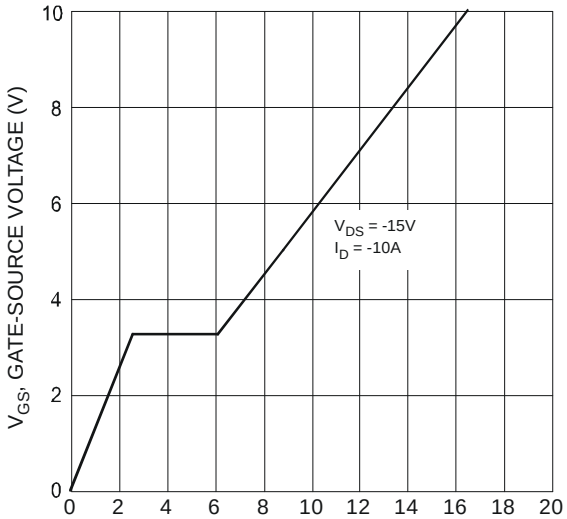


Figure 11 Gate-Charge Characteristics

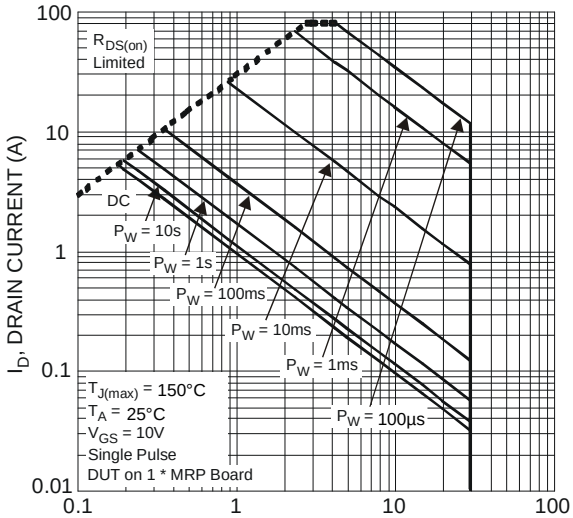


Figure 12 SOA, Safe Operation Area

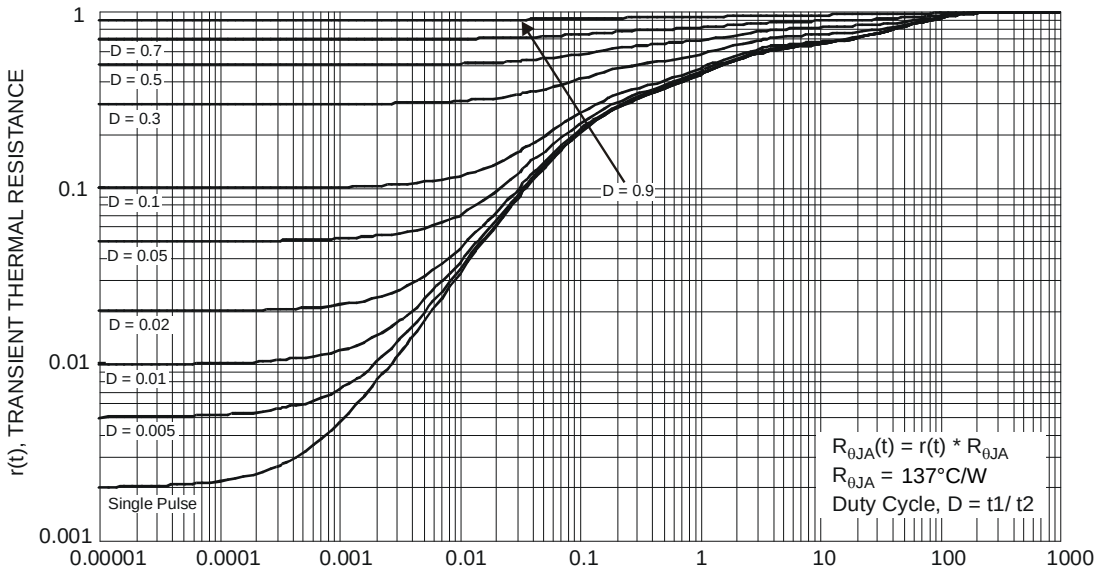
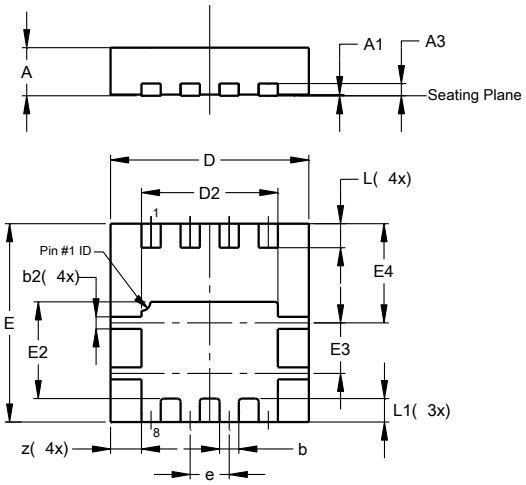


Figure 13 Transient Thermal Resistance

Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI3333-8

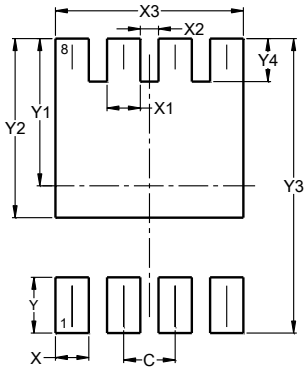


PowerDI3333-8			
Dim	**Min**	**Max**	**Typ**
A	0.75	0.85	0.80
A1	0.00	0.05	0.02
A3	–	–	0.203
b	0.27	0.37	0.32
b2	0.15	0.25	0.20
D	3.25	3.35	3.30
D2	2.22	2.32	2.27
E	3.25	3.35	3.30
E2	1.56	1.66	1.61
E3	0.79	0.89	0.84
E4	1.60	1.70	1.65
e	–	–	0.65
L	0.35	0.45	0.40
L1	–	–	0.39
z	–	–	0.515
All Dimensions in mm			

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

PowerDI3333-8



Dimensions	Value (in mm)
C	0.650
X	0.420
X1	0.420
X2	0.230
X3	2.370
Y	0.700
Y1	1.850
Y2	2.250
Y3	3.700
Y4	0.540

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